

Vishay Siliconix

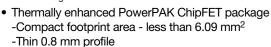
N-Channel 40 V (D-S) MOSFET

PowerPAK® ChipFET® Single S 6 7 8 9 4 3 D D Top View Bottom View

PRODUCT SUMMARY	
V _{DS} (V)	40
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.00775
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$	0.00947
Q _g typ. (nC)	12.6
I _D (A) ^{a, g}	25
Configuration	Single

FEATURES

- TrenchFET® Gen IV power MOSFET
- 100 % R_g and UIS tested

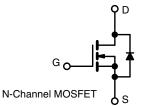




- 56 % lower R_{DS(ON)} than the prior generation
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- DC/DC converters
- · Motor drive control
- · Synchronous rectification
- Battery management
- · Load switch



ORDERING INFORMATION				
Package		PowerP	AK ChipFET	
Lead (Pb)-free and halogen-free		Si5448[DU-T1-GE3	
ABSOLUTE MAXIMUM RATINGS	S (T _A = 25 °C, u	nless other	wise noted)	
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		V_{DS}	40	
Gate-source voltage		V_{GS}	+20 / -16	V

PARAMETER Drain-source voltage		SYMBOL	LIMIT	UNIT	
		V_{DS}	40	V	
Gate-source voltage		V_{GS}	+20 / -16	v	
	T _C = 25 °C		25 ^a		
Continuous drain current (T _J = 150 °C)	T _C = 70 °C	1 ,	25 ^a		
	T _A = 25 °C	l _D	15.9 ^{b, c}		
	T _A = 70 °C	7	12.7 ^{b, c}	^	
Pulsed drain current (t = 100 μs)		I _{DM}	100	A	
Continuous accuracy during disade accuracy	T _C = 25 °C		25 ^a		
Continuous source-drain diode current	T _A = 25 °C	- I _S	2.6 ^{b, c}		
Single pulse avalanche current	1 0.1 ml l	I _{AS}	15		
Single pulse avalanche energy	L = 0.1 mH	E _{AS}	11.25	mJ	
	T _C = 25 °C		31		
Manian and a sure discipation	T _C = 70 °C		20	14/	
Maximum power dissipation	T _A = 25 °C	P _D	3.1 ^{b, c}	W	
	T _A = 70 °C	7	2 ^{b, c}		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) d, e			260	-0	

THERMAL RESISTANCE RATI	NGS				
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT
Maximum junction-to-ambient b, f	t ≤ 10 s	R _{thJA}	34	40	°C/W
Maximum junction-to-case (drain)	Steady state	R_{thJC}	4	4	C/VV

Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s
- 6. See solder profile (<u>www.vishay.com/doc?73257</u>). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 90 °C/W.
- g. $T_C = 25$ °C.



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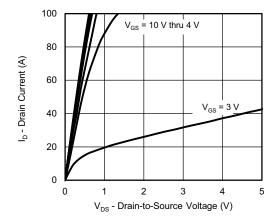
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static				L		
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	21.2	-	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-5.1	-	mV/°C
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	-	2.5	V
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20 \text{ V} / -16 \text{ V}$	-	-	± 100	nA
Zana mata walka sa alusin awana t	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V	-	-	1	
Zero gate voltage drain current		V _{DS} = 40 V, V _{GS} = 0 V, T _J = 70 °C	-	-	10	μA
On-state drain current ^a	I _{D(on)}	$V_{DS} \le 10 \text{ V}, V_{GS} = 10 \text{ V}$	20	-	-	Α
Desire and the second of the second	Б	V _{GS} = 10 V, I _D = 15 A	-	0.00646	0.00775	_
Drain-source on-state resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$	-	0.00790	0.00947	Ω
Forward transconductance ^a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_D = 15 \text{ A}$	-	80	-	S
Dynamic ^b					•	•
Input capacitance	C _{iss}		-	1765	-	
Output capacitance	C _{oss}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	278	-	рF
Reverse transfer capacitance	C _{rss}		-	45	-	
otal gate charge	Qg	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$	-	26.2	40	
			-	12.6	20	0
Gate-source charge	Q _{gs}	$V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$	-	5.1	-	nC
Gate-drain charge	Q_{gd}		-	2.5	-	
Gate resistance	R_g	f = 1 MHz	0.3	1.5	3	Ω
Turn-on delay time	t _{d(on)}		-	10	20	
Rise time	t _r	V_{DD} = 20 V, R_L = 1.7 Ω , $I_D \cong$ 12 A,	-	35	53	
Turn-off delay time	t _{d(off)}	$V_{DD} = 20 \text{ V}, \text{ R}_L = 1.7 \Omega, \text{ I}_D \cong 12 \text{ A},$ $V_{GEN} = 10 \text{ V}, \text{ R}_g = 1 \Omega$		15	30	1
Fall time	t _f		-	10	20	
Turn-on delay time	t _{d(on)}		-	15	30	ns
Rise time	t _r	V_{DD} = 20 V, R_L = 1.7 Ω , $I_D \cong$ 12 A,	-	60	90	1
Turn-off delay time	t _{d(off)}	V_{GEN} = 4.5 V, R_g = 1 Ω	-	18	36	
Fall time	t _f		-	33	50	
Drain-Source Body Diode Characteristi	cs					
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	25	_
Pulse diode forward current	I _{SM}		-	-	100	Α
Body diode voltage	V_{SD}	I _S = 13 A, V _{GS} = 0 V	-	0.8	1.2	V
Body diode reverse recovery time	t _{rr}		-	33	50	ns
Body diode reverse recovery charge	Q_{rr}	1 10 A 11/14 100 A/v- T 05 00	-	30	45	nC
Reverse recovery fall time	t _a	$I_F = 13 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	18	-	
Reverse recovery rise time	t _b		-	15	-	ns

Notes

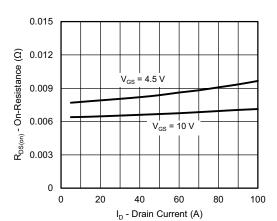
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

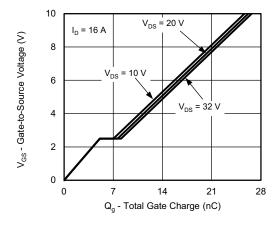




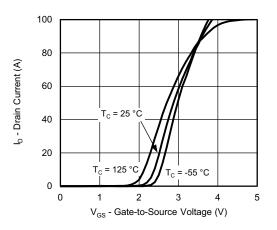
Output Characteristics



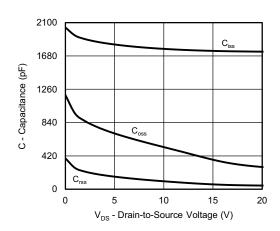
On-Resistance vs. Drain Current and Gate Voltage



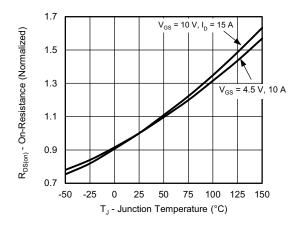
Gate Charge



Transfer Characteristics

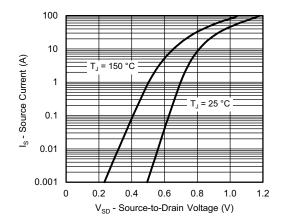


Capacitance

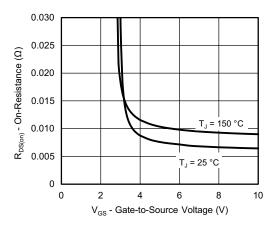


On-Resistance vs. Junction Temperature

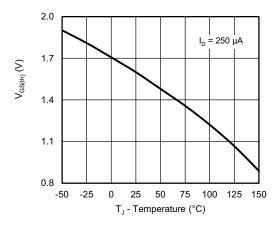




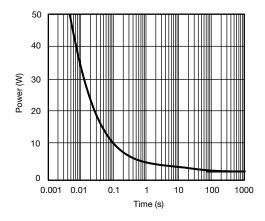
Source-Drain Diode Forward Voltage



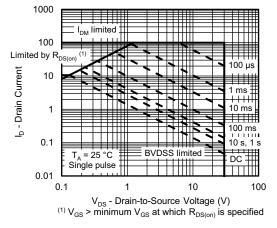
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

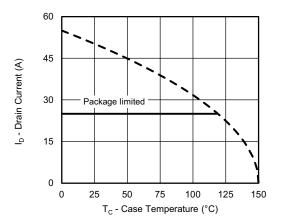


Single Pulse Power, Junction-to-Ambient

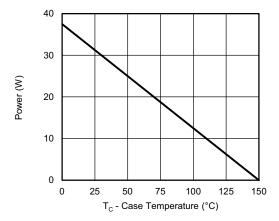


Safe Operating Area, Junction-to-Ambient

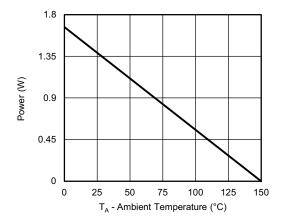




Current Derating a





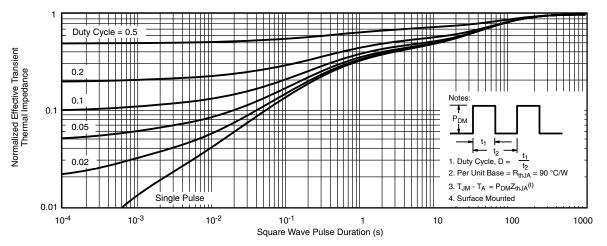


Power, Junction-to-Ambient

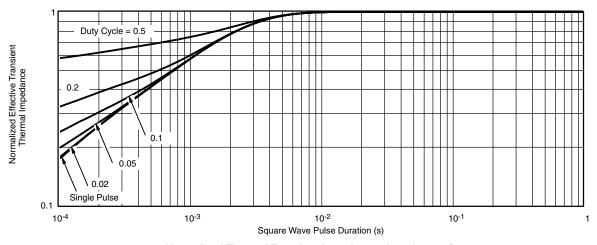
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

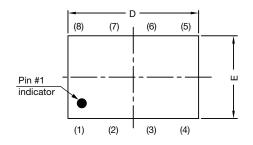


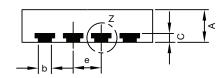
Normalized Thermal Transient Impedance, Junction-to-Case

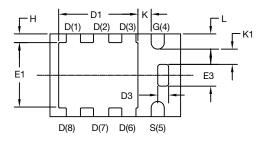
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?76149.



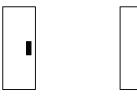
PowerPAK® ChipFET® Case Outline







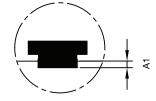
Backside view of single pad



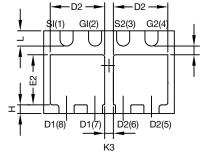
Side view of single



Side view of dual



Detail Z



Backside view of dual pad

DIM.		MILLIMETERS		INCHES			
DIIVI.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.70	0.75	0.85	0.028	0.030	0.033	
A1	0	-	0.05	0	-	0.002	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	2.92	3.00	3.08	0.115	0.118	0.121	
D1	1.75	1.87	2.00	0.069	0.074	0.079	
D2	1.07	1.20	1.32	0.042	0.047	0.052	
D3	0.20	0.25	0.30	0.008	0.010	0.012	
E	1.82	1.90	1.98	0.072	0.075	0.078	
E1	1.38	1.50	1.63	0.054	0.059	0.064	
E2	0.92	1.05	1.17	0.036	0.041	0.046	
E3	0.45	0.50	0.55	0.018	0.020	0.022	
е		0.65 BSC		0.026 BSC			
Н	0.15	0.20	0.25	0.006	0.008	0.010	
K	0.25	-	-	0.010	-	ı	
K1	0.30	-	-	0.012	-	ı	
K2	0.20	-	-	0.008	-	ı	
K3	0.20	-	-	0.008	-	ı	
L	0.30	0.35	0.40	0.012	0.014	0.016	

C14-0630-Rev. E, 21-Jul-14

Note

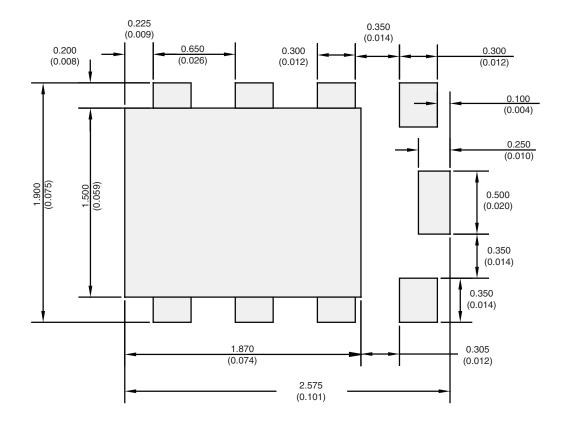
DWG: 5940

Revision: 21-Jul-14

• Millimeters will govern



RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Single



Recommended Minimum Pads Dimensions in mm/(Inches)

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APPLICATION NOTE



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Vishay

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